54F253,74F253

54F253 74F253 Dual 4-Input Multiplexer with TRI-STATE(RM) Outputs



Literature Number: SNOS179A

54F/74F253 Dual 4-Input Multiplexer with TRI-STATE® Outputs

General Description

The 'F253 is a dual 4-input multiplexer with TRI-STATE® outputs. It can select two bits of data from four sources using common select inputs. The output may be individually switched to a high impedance state with a HIGH on the respective Output Enable (OE) inputs, allowing the outputs to interface directly with bus oriented systems.

Features

- Multifunction capability
- Non-inverting TRI-STATE outputs
- Guaranteed 4000V minimum ESD protection

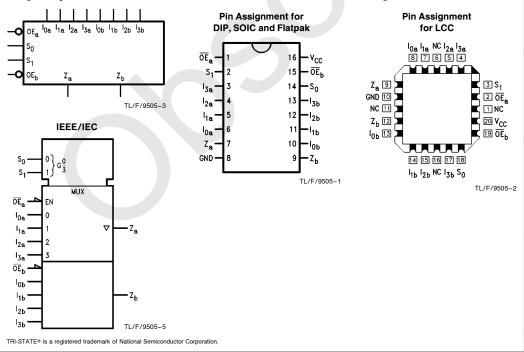
Commercial	Military	Package Number	Package Description
74F253PC		N16E	16-Lead (0.300" Wide) Molded Dual-In-Line
	54F253DM (Note 2)	J16A	16-Lead Ceramic Dual-In-Line
74F253SC (Note 1)		M16A	16-Lead (0.150" Wide) Molded Small Outline, JEDEC
74F253SJ (Note 1)		M16D	16-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F253FM (Note 2)	W16A	16-Lead Cerpack
	54F253LL (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

Logic Symbols

Connection Diagrams



Unit Loading/Fan Out

		54F/74F			
Pin Names	Description	U.L. HIGH/LOW	Input I _{IH} /I _{IL} Output I _{OH} /I _{OL}		
I _{0a} -I _{3a}	Side A Data Inputs	1.0/1.0	20 μA/ – 0.6 mA		
I _{0b} -I _{3b}	Side B Data Inputs	1.0/1.0	20 μA/ - 0.6 mA		
S ₀ -S ₁	Common Select Inputs	1.0/1.0	20 μA/ – 0.6 mA		
ŌĒa	Side A Output Enable Input (Active LOW)	1.0/1.0	20 μA/ – 0.6 mA		
$S_0 - S_1$ \overline{OE}_a \overline{OE}_b	Side B Output Enable Input (Active LOW)	1.0/1.0	20 μA/ - 0.6 mA		
Z_a, Z_b	TRI-STATE Outputs	150/40(33.3)	-3 mÅ/24 mA (20 mA)		

Functional Description

This device contains two identical 4-input multiplexers with TRI-STATE outputs. They select two bits from four sources selected by common Select inputs (S₀, S₁). The 4-input multiplexers have individual Output Enable $(\overline{OE}_a, \overline{OE}_b)$ inputs which, when HIGH, force the outputs to a high impedance (High Z) state. This device is the logic implementation of a 2-pole, 4-position switch, where the position of the switch is determined by the logic levels supplied to the two select inputs. The logic equations for the outputs are shown below:

$$\begin{split} Z_a &= \overline{OE}_a \bullet (I_{0a} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1a} \bullet \overline{S}_1 \bullet S_0 + I_{2a} \bullet \overline{S}_1 \bullet S_0) \\ I_{2a} \bullet S_1 \bullet \overline{S}_0 + I_{3a} \bullet S_1 \bullet S_0) \\ Z_b &= \overline{OE}_b \bullet (I_{0b} \bullet \overline{S}_1 \bullet \overline{S}_0 + I_{1b} \bullet \overline{S}_1 \bullet S_0 + I_{2b} \bullet S_1 \bullet S_0) \end{split}$$

If the outputs of TRI-STATE devices are tied together, all but one device must be in the high impedance state to avoid high currents that would exceed the maximum ratings. Designers should ensure that Output Enable signals to TRI-STATE devices whose outputs are tied together are designed so that there is no overlap.

Truth Table

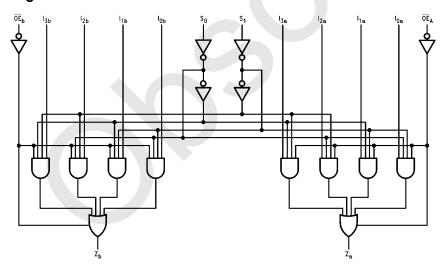
Select Inputs			Data I	Input	s	Output Enable	Output	
S ₀	S ₁	I ₀	I ₁	l ₂	l ₃	ŌĒ	Z	
Χ	Χ	Х	Х	Χ	Х	Н	Z	
L	L	L	Χ	Χ	X	L	L	
L	L	Н	Χ	Χ	X	L	Н	
Н	L	Х	L	Χ	X	L	L	
Н	ı	x	Н	Х	x		н	
Ë	H	x	X	Ĺ	X		i i	
Ĺ	H	X	X	H	X	Ĺ	H	
Н	Н	Х	X	X	L	L	L	
Н	Н	Х	X	Χ	Н	L	Н	

Address inputs S₀ and S₁ are common to both sections.

H = HIGH Voltage Level L = LOW Voltage Level

X = Immaterial Z = High Impedance

Logic Diagram



TI /F/9505-4

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C -55°C to +175°C Junction Temperature under Bias −55°C to +150°C Plastic

V_{CC} Pin Potential to

Ground Pin $-0.5\mbox{V}$ to $+7.0\mbox{V}$ -0.5V to +7.0VInput Voltage (Note 2) Input Current (Note 2) -30~mA to +5.0~mA

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

- 0.5V to V_{CC} - 0.5V to + 5.5V Standard Output TRI-STATE Output

Current Applied to Output

in LOW State (Max)

twice the rated I_{OL} (mA) 4000V

ESD Last Passing Voltage (Min)

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature

Military -55°C to +125°C Commercial 0°C to +70°C

Supply Voltage

 $+\,4.5V$ to $+\,5.5V$ Military Commercial +4.5V to +5.5V

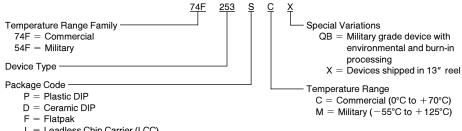
DC Electrical Characteristics

Symbol	Parameter		54F/74F			Units	V _{CC}	Conditions	
Symbol			Min	Тур	Max	Onits	•00	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V_{IL}	Input LOW Voltage				0.8	٧		Recognized as a LOW Signal	
V_{CD}	Input Clamp Diode Vo	Input Clamp Diode Voltage			-1.2	V	Min	$I_{\text{IN}} = -18 \text{ mA}$	
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 54F 10% V _{CC} 74F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC} 74F 5% V _{CC}	2.5 2.4 2.5 2.4 2.7 2.7			>	Min	$\begin{split} I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \end{split}$	
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}			0.5 0.5	V	Min	$I_{OL} = 20 \text{ mA}$ $I_{OL} = 24 \text{ mA}$	
I _{IH}	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	V _{IN} = 2.7V	
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	V _{IN} = 7.0V	
I _{CEX}	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage Test	74F	4.75			٧	0.0	$I_{\text{ID}} = 1.9 \mu\text{A}$ All Other Pins Grounded	
I _{OD}	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
lozh	Output Leakage Current				50	μΑ	Max	$V_{OUT} = 2.7V$	
lozL	Output Leakage Current				-50	μΑ	Max	$V_{OUT} = 0.5V$	
los	Output Short-Circuit Current		-60 -100		−150 −225	mA	Max	$V_{OUT} = 0V$ $V_{OUT} = 0V$	
I _{ZZ}	Bus Drainage Test			500	μΑ	0.0V	$V_{OUT} = V_{CC}$		
Icch	Power Supply Current			11.5	16	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current			16	23	mA	Max	V _O = LOW	
I _{CCZ}	Power Supply Curren		16	23	mA	Max	V _O = HIGH Z		

		$74F$ $T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			54F T _A , V _{CC} = Mil C _L = 50 pF		74F T _A , V _{CC} = Com C _L = 50 pF		Units
Symbol	Parameter								
		Min	Тур	Max	Min	Max	Min	Max	
t _{PLH} t _{PHL}	Propagation Delay S_n to Z_n	4.5 3.0	8.5 6.5	11.5 9.0	3.5 2.5	15.0 11.0	4.5 3.0	13.0 10.0	ns
t _{PLH} t _{PHL}	Propagation Delay I _n to Z _n	3.0 2.5	5.5 4.5	7.0 6.0	2.5 2.5	9.0 8.0	3.0 2.5	8.0 7.0	ns
t _{PZH} t _{PZL}	Output Enable Time	3.0 3.0	6.0 6.0	8.0 8.0	2.5 2.5	10.0 10.0	3.0 3.0	9.0 9.0	ns
t _{PHZ}	Output Disable Time	2.0 2.0	3.7 4.4	5.0 6.0	2.0 2.0	6.5 8.0	2.0 2.0	6.0 7.0	113



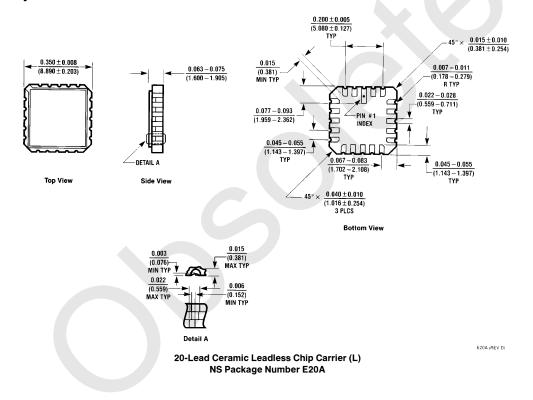
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:

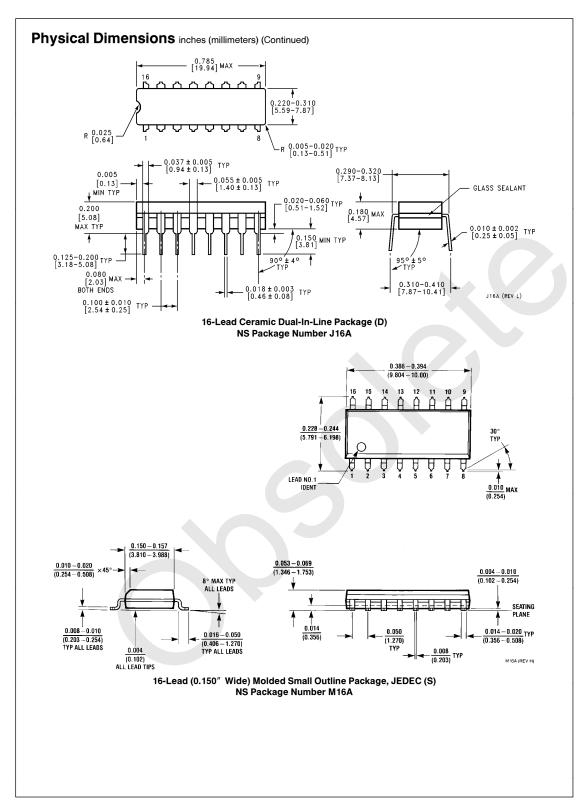


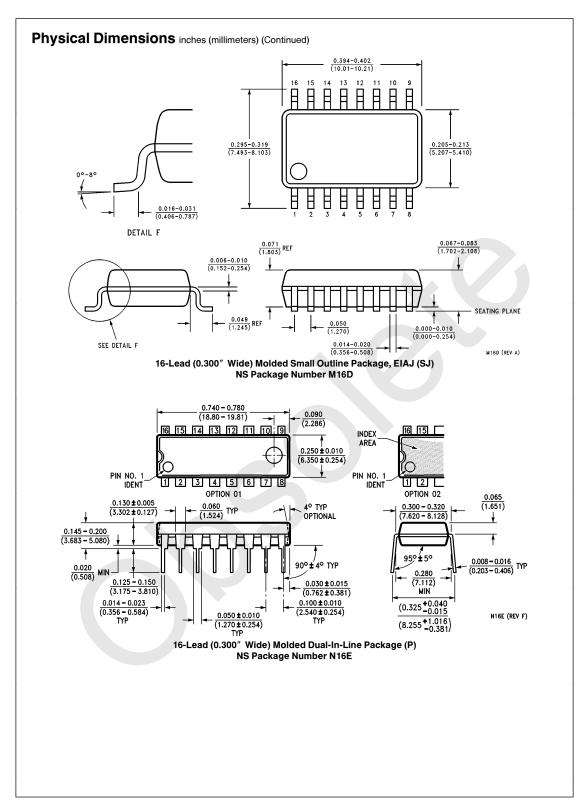
L = Leadless Chip Carrier (LCC) S = Small Outline SOIC JEDEC

SJ = Small Outline SOIC EIAJ

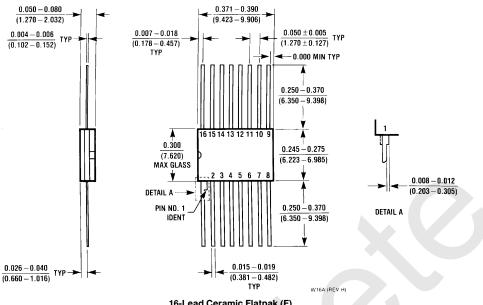
Physical Dimensions inches (millimeters)







Physical Dimensions inches (millimeters) (Continued)



16-Lead Ceramic Flatpak (F) NS Package Number W16A

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